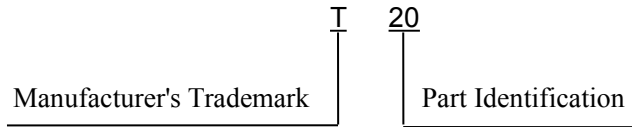
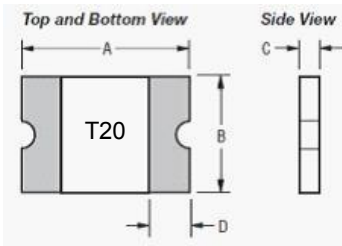


## Product Introduction

### 1. Product Dimensions & Outline Drawing & marking (Unit:mm)



Model	A		B		C		D
	Min.	Max.	Min.	Max.	Min.	Max.	
NSMD200	3.00	3.50	1.40	1.80	0.80	1.20	0.25

### 2. Electrical Properties

Model	$I_H$ (A)	$I_T$ (A)	$V_{max}$ (V)	$I_{max}$ (A)	T (Max time to trip)		$Pd_{typ}$ (W)	$R_{min}$ ( $\Omega$ )	$R1_{max}$ ( $\Omega$ )
					(A)	(S)			
NSMD200	2.00	4.00	16	100	8.00	1.00	0.70	0.020	0.120

$I_H$ : Holding Current: maximum current at which the device will not trip in 25°C still air.

$I_T$ : Tripping Current minimum current at which the device will trip in 25°C still air.

$V_{max}$ : Maximum voltage device can withstand without damage at rated current.

$I_{max}$ : Maximum fault current device can withstand without damage at rated voltage.

$T_{trip}$ : Maximum time to trip(s) at assigned current.

$Pd_{typ}$ : Rated working power.

$R_{min}$ : Minimum resistance of device prior to trip at 25°C.

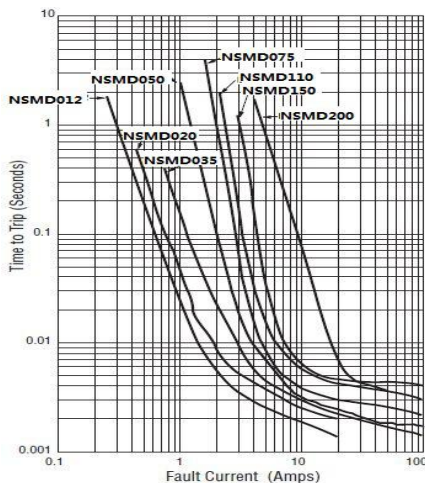
$R_{max}$ : Maximum resistance of device prior to trip at 25°C.

$R1_{max}$ : Maximum resistance of device is measured one hours post reflow at 25°C.

### 3. Thermal Derating Chart – $I_{hold}$ (Amps)

Model	Ambient Operating Temperature								
	-40°C	-20°C	0°C	25°C	40°C	50°C	60°C	70°C	85°C
NSMD200	2.88	2.61	2.28	2.00	1.80	1.66	1.51	1.39	1.19

### 4. Typical time to trip at 25°C



- ◆ Time to Trip curves represent typical performance of a device in a simulated application environment. Actual performance in specific customer applications may differ from these values due to the influence of other variables.